Applicant(s)/Patent Under Application/Control No. Reexamination 10/615,213 BAY ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1625 Rita J. Desai **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY WO95/28838 11-1995 WO Ν Leone-Bay et al 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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